Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination NAKASHIMA, ATSUHISA	
10/614,080		
Examiner	Art Unit	
Shih-wen Hsieh	2861	

	SEARCHED				
Class	Subclass	Date	Examiner		
updated	updated	3/8/2005	mm swh		
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INTERFERENCE SEARCHED			
Class.	Subclass	Date	Examiner
347	32,104	3/8/2005	SWH
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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